Operator’s Manual
WaveLink Low-Bandwidth
(4 GHz, 6 GHz) Differential Probe
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Safety Instructions
To maintain the probe in a correct and safe condition, observe generally accepted safety procedures in addition to the precautions specified in this section. The overall safety of any system incorporating this product is the responsibility of the assembler of the system.

Symbols
These symbols appear on the probe and accessories or in this manual to alert you to important safety considerations.

- **CAUTION** of damage to instrument, or **WARNING** of hazard to health. Attend to the accompanying information to protect against personal injury or damage. Do not proceed until conditions are fully understood and met.

- **ESD CAUTION.** Risk of Electrostatic Discharge (ESD) that can damage the probe or instrument if anti-static measures are not taken.

Precautions

**WARNING.** To avoid personal injury or damage due to electric shock or fire:

- **Do not overload; observe all terminal ratings.** Do not apply any potential that exceeds the maximum rating of the probe and/or the probe accessory, whichever is less.

- **Comply with the Voltage vs Frequency derating curve** when measuring higher frequency signals.

- **Connect and disconnect properly.** Always connect the probe input leads to the probe accessory before connecting to a voltage source. Ensure connections are secure before applying voltage.

- **Keep the probe body and output cable away from the circuits being measured.** Only accessory tips are intended for contact with electrical sources.

- **Use only accessories compatible with the probe.** Use only accessories that are rated for the application.
CAUTION. To avoid damaging the equipment:

**Use only as specified.** The probe is intended to be used only with compatible Teledyne LeCroy instruments. Use of the probe and/or the equipment it is connected to in a manner other than specified may impair the protection mechanisms.

**Do not bend cables excessively.**

**Use only within the operational environment listed.** Do not use in wet or explosive atmospheres.

**Keep product surfaces clean and dry.**

**Do not operate with suspected failures.** Before each use, inspect the probe and accessories for any damage such as tears or other defects in the probe body, cable jacket, accessories, etc. If any part is damaged, cease operation immediately and sequester the probe from inadvertent use.

**Operating Environment**

The accessory is intended for indoor use and should be operated in a clean, dry environment. Before using this product, ensure that its operating environment is maintained within these parameters:

**Temperature:** 5° to 40° C.

**Humidity:** Maximum relative humidity 90 % for temperatures up to 31°C decreasing linearly to 50 % relative humidity at 40°C.

**Altitude:** Up to 10,000 ft (3,048 m).

**Specifications**

Full probe specifications are available from the WaveLink product page on our website at: teledynelecroy.com(probes

**NOTE:** Specifications are subject to change without notice.
Introduction

Teledyne LeCroy’s WaveLink 4 GHz and 6 GHz Differential Probes are a general purpose probing solution with high-input dynamic range and offset range capability. The range of capabilities is ideal for a variety of high-speed DDR signals where high dynamic range and large offset requirements are common.

The wide variety of tips offered with the Dx10/Dx20 provides confidence that the most challenging test points can be probed. With seven different tips available, the Dx10/Dx20 provides great flexibility when probing, while maintaining signal integrity. An assortment of hands-free probe holders eases the challenge of connecting multiple leads to a board.

WaveLink probes provide superior loading characteristics and are calibrated with a custom “fine-tuned” frequency response. The ultra-low loading coupled with a flat frequency response ensure accurate measurements.

The unique QuickLink architecture allows for probe tips to be quickly attached to or removed from a WaveLink differential amplifier. Unlike other “consumable” probe tip solutions which rely on tiny, delicate tips located very close to the Device Under Test (DUT), the QuickLink Solder-In tip has an integral 9-inch lead. QuickLink Solder-In tips are low cost, making it easy to equip multiple test points and DUTs while eliminating time-consuming resoldering of connectors.

NOTE: The Certificate of Calibration shipped with each probe indicates that the system meets the specifications when using the components listed in the Certificate. Download the latest version of X-StreamDSO™ oscilloscope firmware to run your WaveLink probe with maximum performance.

ESD Sensitive: The tips of the WaveLink probes are sensitive to Electrostatic Discharge (ESD). Avoid causing damage to the probe by always following anti-static procedures when using or handling the probe.
Modular Design
The WaveLink probe design consists of a Platform/Cable Assembly matched to either of two differential amplifiers: a Small Tip Module supplied with various interconnect leads, or an Adjustable Tip module. The variety of interchangeable leads eliminates the need for external wires or other accessories in the high-impedance path of the input signal, assuring proper transmission of the signal as it passes through the probe.

WaveLink 6 GHz and 4 GHz Probe Families

At time of shipment, Teledyne LeCroy serializes the components and calibrates them as a system. To achieve maximum performance and warranted specifications, the calibrated components should be used together. If additional components are purchased, you may return the serialized system to Teledyne LeCroy for re-calibration to ensure performance.
## Probe Accessories

### Standard Accessories Table

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<td>Dxx0-A</td>
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### Small Tip Amplifier Module

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### Adjustable Tip Amplifier Module

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**NOTE:** While the amplifiers can be used with either platform/cable assembly, system bandwidth is limited to the lowest bandwidth component. System calibration is required for all interconnected components to guarantee system performance.
Probe Components

Platform/Cable Assembly

The platform/cable assembly forms the foundation of the probe, attaching the amplifier to the oscilloscope channel. It is supplied in two configurations.

The WL-PBUS2 platform is for use with either ProBus or ProBus2 oscilloscope interfaces. It is compatible with legacy WaveLink amplifiers originally supplied for use with WL-PBUS. The platform is fitted with a locking lever (not shown in the image below) that must be kept locked after connecting to the oscilloscope to ensure full bandwidth capabilities. See p.18.

Note: Although all amplifiers are physically interchangeable with any platform/cable assembly, bandwidth is limited to the lowest bandwidth component, and performance is only guaranteed for components that are calibrated and serialized together. Although the ProBus2 interface is rated to 8 GHz, the WL-PBUS2 platform is only rated to 6 GHz when used with D610-A and D620-A amplifiers.

WL-PLINK for use with the ProLink interface.

 WL-PBUS2 Platform/Cable Assembly provided with D4x0-A-PB2, D6x0-A-PB2 and Dx00A-AT-PB2 probes.

 WL-PLINK Platform /Cable Assembly provided with D6x0-A-PL and D600A-AT-PL probes.
WaveLink Low Bandwidth (4 GHz and 6 GHz) Differential Probe

The platform/cable assembly:

- Provides power to the probe amplifier from the oscilloscope.
- Communicates to the oscilloscope the identifying characteristics of the amplifier that is connected to the probe so that the oscilloscope channel can be set to the correct probe attenuation value automatically (software prompts you to identify the tip used).
- Transmits the amplifier output along a well-defined low loss transmission line into the oscilloscope input, and terminates the probe appropriately at that point.

It is delivered with a variety of accessories in a deluxe, soft carrying case.

WL-PLINK shown with accessories and case.
**Differential Amplifier Small Tip Module**

The amplifier modules contain the active, differential amplifier circuitry and perform the important task of amplifying the low-level signal at the probe tip for transmission via the platform/cable assembly. A selection of interconnect leads/tips with different electrical and physical characteristics, allowing you to choose the tip appropriate for the application.

**Solder-In Lead**

The Solder-In (SI) lead provides the highest possible performance in stationery installations. The design of the SI lead minimizes circuit AC loading by providing high probe AC loading over a wide frequency range. The SI lead is supplied with:

- Two pre-installed and pre-trimmed attenuating (damping) resistors connected to the flexible transmission line. The resistors are soldered directly into the connection points of the circuit under test, providing a reliable, intermittence-free connection.

- Five replacement damping resistors.

The pre-installed resistor design eliminates the need to custom cut and solder lengths of wire to the end of the lead and to the DUT. Damping resistors may be easily replaced in the field to provide maximum serviceability over the life of the SI lead.

The very small and precisely cut resistors have the advantage of locating the damping resistance of the probe tip as close to the DUT as possible, thereby eliminating the need for long lengths of wire which can impact loading and frequency response. The two resistors may be spaced as desired to connect to a wide variety of circuits.

**Square Pin Lead**

The Square Pin (SP) lead can be used on boards where standard 0.025” square pins are used for interconnect. The highly flexible, 145 mm (5.7”) long Square Pin lead connects directly with a pair of square pins mounted on standard 0.100” (2.54 mm) centers.

Because of the parasitic inductance of the square pins, the probe will not support maximum bandwidth or minimum rise time when used with an oscilloscope with greater than 3 GHz bandwidth. The added inductance of the square pins limits the measurements to signals of 3 GHz or lower bandwidth.

**Quick Connect Lead**

The Quick Connect (QC) lead allows the probe to be moved quickly between different test points of the circuit. A pair of small damping resistors (supplied with the probe) is soldered to the circuit’s test points, while the ends of the damping resistors plug into the small connector at the probe tip for a reliable, quick connection. Two sets of 10 resistors are shipped with the probe. This lead set is limited to 4 GHz bandwidth.
**Ground Lead and Clip**
The Ground Lead (PACC-LD005) and the Ground Clip (PK006-4) are used to connect to ground of the circuit under test. While the ground lead is not required for high-frequency measurements, it can help to ground floating test circuits to keep the common mode within the maximum specified range.

**Adjustable Tip Module**
The D400A-AT-PB2, D600A-AT-PB2, and D600A-AT-PL probes are delivered with an Adjustable Tip Module instead of the Small Tip Module with interchangeable tips.

With two highly flexible NiTiNOL alloy tips, the Adjustable Tip Module allows for easy probing of very dense circuitry. It connects directly to the platform/cable assembly and can be used in hand-held applications for rapid test point browsing. The spacing of the tips can be adjusted to accommodate any test point spacing from < 0.1 mm (0.004”) to 3 mm (0.12”).

A protective cover is provided as a standard accessory to help prevent damage to the Adjustable Tip Module. The flexible NiTiNOL-alloy tips are very durable, but can be damaged when enough stress is applied (and result in erroneous measurements).

⚠️ **CAUTION:** To avoid tip damage, always attach the cover to the module when not in use.
Optional Accessories
These special-use leads may be purchased to augment the performance of a WaveLink probe.

*Positioner Tip (Browser) Kit*
The Positioner Tip (PT) provides the ability to access the signal on the DUT without permanently attaching a lead or other device. It combines high performance with quick access to a variety of probe points when used as a hand-held browser (with the wand attachment). When used with a positioner tool, it is a fast and convenient method to re-position a fixed test point.

The pogo pin tips are adjustable from 0 to 3.5 mm (0 to 0.14") and have 0.6 mm of Z-Axis compliance. Because of its thin form factor and spring-loaded tips, the positioner tip is ideally suited for use with multiple probes in tight areas such as the back side of boards with ball-grid array packaged ICs.

Two replacement resistive tips are provided with the positioner tip. These tips may be replaced in the field if damaged.

*HiTemp SI Lead and Cable*
The HiTemp cable and SI lead are used for controlled situations where a differential amplifier module normally needs to be removed from the extreme temperature environment. Ideally suited for testing scenarios where the temperature can fluctuate from -40 °C to +105 °C, the 90 cm matched cable pair and Solder-In lead provides an easy and robust connection to the device under test while allowing access into environmental chambers. The HiTemp probe cables and SI lead pair with the D6x0 and D4x0 differential amplifier modules for full-system bandwidth, excellent signal fidelity, and superior noise performance.
QuickLink Adapter Pack
The QuickLink Probe Adapter enables you to connect QuickLink Solder-In (QL-SI) tips to WaveLink amplifier modules. QL-SI tips may be used with the HDA125 Digital Analyzer for digital signal input, or switched to a WaveLink amplifier for analog signal input of the same probing point. The adapter is purchased as a set with three QL-SI tips (Dx10/Dx20-QL-3SI). Replacement QL-SI tips are also available for purchase separately.
Probe Operation

Interchangeability and Calibration
Teledyne LeCroy WaveLink probes are factory calibrated and performance verified on shipment. Each configured probe is shipped with a Certificate of Calibration indicating that the system performance was found to meet or exceed the warranted specifications when using those components listed in the Certificate. As only this configuration was validated, the certificate is only valid for the configuration indicated. A serial number is affixed to each calibrated component; you must match the serial numbers on all components to ensure guaranteed performance.

Amplifier Modules
Although any amplifier module can mechanically mate with any platform/cable assembly, specifications are only guaranteed when the amplifier is used with the platform/cable assembly to which it has been calibrated and serialized (generally, the one with which it is delivered).

NOTE: System bandwidth is limited to the lowest bandwidth component. System calibration is required for all interconnected components to guarantee system performance. If incorrect or uncalibrated amplifier modules and platform/cable assemblies are connected, a warning is displayed on the oscilloscope touch screen.

Leads/Tips
Although all interconnect leads mechanically mate with any amplifier module, they are only compatible with the same-numbered amplifier (e.g., Dx10-QC with D410-A).

The interconnect leads are designed to keep response within a narrow range and so are interchangeable from amplifier to amplifier provided they are the same number, and interconnect leads manufactured at the same time have nearly identical performance. Likewise, if a damping resistor on the SI lead is replaced using the procedure for "Replacing Damping Resistors on the Solder-in Interconnect Lead" (on page 39), performance is still guaranteed. If an interconnect lead is damaged beyond field repair and requires factory replacement, Teledyne LeCroy recommends that you return the platform/cable assembly, amplifier module, and leads to the factory for a complete re-calibration to ensure guaranteed performance, because there may be small differences in performance of interconnect leads supplied at different times.
Probe Loading and Frequency Response

Teledyne LeCroy probes are factory calibrated using a Vector Network Analyzer (VNA) to measure a system (probe plus test fixture) frequency response. The test fixture is de-embedded from the measurement using Teledyne LeCroy’s Eye Doctor tools so the remaining frequency response is due to the combination of the test signal and the probe loading on the test circuit. The system frequency response is then calculated for these remaining circuit elements.

During calibration, each probe amplifier has a response file created and stored on-board. When the probe is connected to your Teledyne LeCroy oscilloscope, the on-board response file is read by your oscilloscope, and a combined optimized probe + oscilloscope response is created for your particular oscilloscope and channel to which the probe is connected. The response is identical to that of the oscilloscope channel.

All that is left for the operator is to de-embed the probe loading from the circuit using Teledyne LeCroy’s Virtual Probe software option, if desired. Since the Teledyne LeCroy probe impedance is very high across the passband, this may not even be necessary.

To de-embed probe loading, use the appropriate equivalent circuit model in "Probe Input Impedance and Loading" on page 62 and Teledyne LeCroy’s Eye Doctor tools.

You can also use Teledyne LeCroy’s Virtual Probe option, which allows you to select the probe tip from a list of supported tips. Your selection applies a corresponding S-parameter file that is derived from the equivalent circuit model of the tip.

Handling the Probe

The WaveLink series probe is a precision test instrument. Exercise care when handling and storing the probe. Always handle the probe by the platform/cable assembly. Avoid putting excessive strain on the cables or bending them sharply.

ESD Sensitive: The tips of the probe are sensitive to Electrostatic Discharge (ESD). Always follow anti-static procedures (wear wrist strap, etc.) when using or handling the probe.

CAUTION: Store tips in the plastic protective storage case. Always attach the plastic cover to the Adjustable Tip module when not in use.

CAUTION: Positioner Tip tips are very small and are fragile. When not in use, store them in the provided case.
Connecting an Amplifier Module to a Platform/Cable Assembly

Attach the amplifier module to the platform/cable by aligning the connectors of the module with the receptacles in the platform/cable assembly and pressing the two together. Finger tighten the assembly by rotating the threaded collar onto the module.

⚠️ **CAUTION.** Do not use pliers or any other tools to tighten the collar.

Remove the module by loosening the threaded collar and pulling the two assemblies apart.

The same procedures may be used for the Adjustable Tip module.
Connecting Interconnect Leads/Tips to the Amplifier
Align the flat side of the lead connector housing with the flat side of the amplifier and press together. Match the color-coding on the connector housing with the color-coding on the corresponding probe tip and press together.

_Si, SP, QC, and PT Interconnect Lead_

QuickLink Probe Adapter and QL-SI Lead
Hi-Temp Interconnect Lead

Positioning Interconnect Leads

Normally, the performance of the interconnect leads is not affected by the position of the amplifier module. They can be mounted straight upright or on an angle.

However, when it is necessary to mount the module parallel to the board, the maximum performance is obtained when the “+” sign (printed near the positive input tip) is facing up.

The flexible cable connecting the tip of the lead to the amplifier module is reasonably insensitive to placement, but can be affected by large signal emitters on the device under test, so avoid placing it near these types of signals.
Connecting the Platform to a Teledyne LeCroy Oscilloscope

**WL-PLINK**
The WL-PLINK platform/cable assembly has been designed for use with the ProLink interface of Teledyne LeCroy oscilloscopes.

Attach the platform/cable assembly to the instrument by aligning the connector with the input and pushing the interface toward the instrument. You will hear a click when the connector latches to the test instrument. Tighten the thumbscrews to secure the assembly to the instrument. **Do not overtighten the thumbscrews.**

To remove the WL-PLINK assembly from the instrument, loosen the thumbscrews and move the connector up and down while gently pulling until a click is heard. This click indicates the assembly is detached from the instrument.

**WL-PBUS2**
The WL-PBUS2 is designed for use with the ProBus and ProBus2 interfaces of Teledyne LeCroy oscilloscopes.

Before connecting the platform to the oscilloscope, open the locking lever by switching it to the leftmost position (opposite facing arrows). Press the connector head onto the oscilloscope connector, then close the locking lever by the switching it to the rightmost position (closed lock).

**CAUTION.** Failing to close the locking lever will negatively impact probe performance. Full bandwidth is only guaranteed with the lock closed.

Thumbscrews are not provided on the WL-PBUS2 assembly. Disconnect the WL-PBUS2 assembly by opening the locking lever, then pulling the connector head from the interface.

Connecting the Probe to the Test Circuit

For all modules and interconnect leads/tips, positive voltages applied to the + input relative to the – input deflects the oscilloscope trace towards the top of the screen.

Exercise care when connecting the probe to the test circuit to maintain the high frequency capability of the probe in measurement applications. Increasing the parasitic capacitance or inductance in the input path may introduce a ring, or slow the rise time of fast-rising signals. Any extension of the signal path with extra wire leads, etc. adversely affects the probe’s performance.

A ground connection is generally not required for most probing applications. Refer to Probe Grounding (on page 26) for more information.
**Solder-In Lead**

The Solder-in Lead for the amplifier module is supplied with two pre-installed resistors, which are intended to be soldered to the runs or pad test points on the board under test. Because the resistors and the leads are small, this interconnect lead provides the maximum signal fidelity at the highest frequency response.

Using a small soldering iron tip, attach the free wires of the resistors to the appropriate test points by carefully following the directions in the following sections.

**NOTE:** The entire SI tip should be positioned with the resistor side upright facing (away from the PCB plane). Keep a 45 degree angle between the SI tip ends and the PCB plane. The SI lead provides better signal fidelity performance with high frequency signals if it is elevated in this manner. The tip clip also helps to secure and reinforce the SI resistive tips, and can be used to position the resistor leads when soldering the resistors to the test points.

**CAUTION:** The resistors are small in order to maintain high-frequency performance. However, they are not sturdy enough to bear the weight of the probe module. It should be supported by other means. A positioning tool such as the Board Clip, the Probe Tip Retaining Clip, or EZ Probe positioner can be used to support the probe.
Properly bending the SI Lead tips results in a more consistent response. Upon first receiving your SI Lead, the tips are not likely to be positioned for optimal performance when soldered to your trace. The goal is to get the resistor bodies to be parallel and the tips bent to sit on the test board traces.

1. Bend the resistor bodies to position them parallel.

2. Bend the tips in toward the center. Make the bend as close to the resistor body as possible. Bend them to about 60° from straight.

3. At this point, the leads can be bent from their midpoints so they are parallel to each other.

4. Perform a final check to ensure proper lead spacing and compare them to the trace spacing on the PCB.
**Quick Connect Lead**

The Quick Connect (QC) lead can be used in applications requiring the probe to be moved to multiple test points.

To accurately position the resistors for soldering, first plug one end directly into the special connector mounted on the probe input board. Then, position the tip and solder the other end of the resistor to the testing point. Repeat this process when installing resistors on other test points.

A positioning tool like the Probe Tip Retaining Clip can be used to aid in holding the QC lead in place for soldering.

**NOTE:** For maximum performance, do not extend the resistor wires or use different resistors.

**CAUTION:** Do not confuse the Quick Connect lead with the Square Pin lead. The Square Pin lead is clearly labeled with the initials “SP” printed on the square pin receptacle housing. The Quick Connect lead has been designed to accept only the wire diameter of the small damping resistors, not the 0.025” thickness of the square pin. Inserting square pins into the connector of the Quick Connect Lead could damage the wire receptacle of the lead.
**Square Pin Lead**

Insert the head of the Square Pin lead directly over standard 0.025” square pins mounted on 0.100” centers.

The system bandwidth and rise time are limited by the Square Pin lead because of the inherent inductance of the square pins themselves.

Keep the highest possible performance by keeping the parasitic inductance under control. Also, make good electrical connections by not using any square pins longer than 2.79 mm (0.110”) or shorter than 2.54 mm (0.100”).
**Positioner Tip (Browser)**

The Positioner Tip (Browser) has a very small form factor with very low mass. It is a good all-around browsing or mounted solution for probing in areas with a high concentration of test points or limited free space to fit a probe.

Various attachments and extenders are supplied with the Positioner Tip (PT), allowing it to be easily held while browsing or connected to a mounting device. Using these attachments, the tip can be positioned in many different ways to make probing possible in tight geometries.

![Wand](image1)
![Tripod](image2)
![EZ-Probe Mount](image3)

Rotate the thumbwheel to adjust the tip spacing from 0 to 3.5 mm (0 to 0.14") in a direction perpendicular to the thumbwheel rotation. There is a positive stop on the thumbwheel to prevent it from being rotated too far in either direction.

The tip is a pogo-pin assembly and is spring-mounted to accommodate 0.6mm of Z-Axis compliance. This aids in applications where more than one positioner tip is required to make measurements in a crowded area, and the tips need to be mounted at an angle to the board under test.

**NOTE:** Some mechanical positioners (such as the EZ probe) may exert excessive Z-Axis compliance during setup, so be extra careful with these types of mechanical positioners.

Avoid applying excessive lateral pressure on the tip as it may break. Do not use the tip to scrape the circuit. If the tip does break, it may be replaced in the socket. If the socket also breaks, a new socket can be soldered onto the tip. See Replacing Spring-Loaded Tips and Tip Sockets on Positioner Tips (on page 40).
Adjustable Tip Module (-AT)

The spacing of the flexible, nickel-titanium alloy tips can be adjusted by rotating the knurled thumbscrew on the top of the module to accommodate different test point spacing from less than 0.1 mm to > 3 mm.

For accurate measurements, both the + and − inputs must always be connected to the test circuit.

**NOTE:** When making differential measurements, both tips need to make good contact. The best way to accomplish this is to place one tip on one test point, apply a little pressure and by rotating the probe body slightly, place the other tip on the other test point. Assure good contact and apply enough pressure to bend the tips just a bit.

Excessive bending of these tips may damage the module beyond repair. However, the tips are flexible enough to allow both tips to make good contact with the circuit under test even when the probe is slightly rotated with respect to the circuit under test.

**NOTE:** Always support the probe to prevent too much stress on the pins of the Adjustable Tip Module.
**QL-SI Tip**

Attach QL-SI Tips as you would any solder-in lead tip. Once soldered to the board, the QL-SI tips can be switched from the WaveLink probe to an HDA125 High-speed Digital Analyzer by pulling the tip head from the amplifier and plugging it into the digital leadset pod, or vice versa.

**Probe Grounding**

In most cases, when the common mode portion of the signal consists mainly of lower frequencies, the probe does not need to be connected to the ground of the circuit under test. This minimizes the effects of ground loop currents. Any signal corruption caused by not having the probe connected to ground of the signal under test is common to both inputs and is rejected by the differential operation of the probe.

Capacitive coupling from AC mains may cause truly floating devices (like battery operated devices) to exceed the common mode range. In such cases, or in environments with high RF ambient noise, it is recommended to connect the probe ground to the device under test. Connect the plug of the ground lead to the receptacle located on the side of the amplifier/adjustable tip module body.

- In floating devices, attach the probe ground lead to the DUT’s reference or common voltage.
- In high RF ambient noise environments, attach the probe ground lead to a good RF ground near the point where the signal is being measured.
**WaveLink Low Bandwidth (4 GHz and 6 GHz) Differential Probe**

**CAUTION:** Always use a ground lead when testing floating circuits. Floating circuitry such as circuits powered from laboratory bench power supplies, which normally have floating outputs, may damage the probe by exceeding the common mode input voltage.

**Using Positioning Tools**
Positioning tools support the platform/cable assembly and amplifier module. They reduce the risk of damaging runs or pads on the board. Always use a positioning tool to support your probe.

*FreeHand Probe Holder*

The freehand probe holder (PACC-MS001) is provided as a standard accessory with the WL-PLINK or WL-PBUS2. It is designed to keep most of the weight on the probe tip to prevent loss of contact with the circuit under test. The freehand is a stable, easy-to-set-up probe positioner, improving your ability to concentrate on the measurement by not having to hold the probe.

*Dxx0-PT-XYZ-Positioner*

This positioner is a small, lightweight device that can be affixed to the printed circuit assembly using the included adhesive pads. The black adhesive pads are for more permanent attachment, whereas the white adhesive pads leave less residue when removed. The wide variety of short, long, swivel, and right angle interconnect parts can be connected to the top assembly, which can then be moved up and down along the Z-Axis to increase or release pressure on the probe points. The bottom assembly contains a tightening wheel which can be loosened to allow minor X-Y axis adjustments, and then tightened to fix the exact probing position.
EZ Probe Positioner

The Cascade Microtech EZ-Probe Positioner is available as an optional accessory. It provides stable, accurate positioning in the X-Y-Z axes. The unique 3:1 motion reduction joystick allows simple, precise positioning of the attached probe in both the horizontal and vertical measuring plane. The probe has a fully-articulating arm, providing 30 cm (12 inch) reach in virtually any direction.

The XYZ joystick has separate friction controls allowing independent X-Y plane or Z-Axis movement and is especially useful when combined with the positioner tip.

The EZ-Probe Positioner comes with a vacuum mounted base to keep the probe in place in any test environment, although the solid base is heavy enough that the positioner can be used without the vacuum.

EZ Probe Positioner Using DX10-PT and DX20-PT

Attach the probe by first removing the screws holding the top plate to the V-shaped probe holder. Rest the Long Interconnect Extender in the V-shaped groove, and fasten the top plate to the holder, using the removed screws (as follows). Then, insert the Dx10 or Dx20-PT onto the Long Interconnect Extender.

**NOTE:** Do not over-tighten the screws.

Once the probe has been attached, loosen the knob on the EZ-Probe Positioner arm and position the probe close to the test point. Tighten the knob and use the joystick to fine position the probe.
Ez Probe Positioner Using Dx00A-AT

Attach the probe by first removing the screws holding the top plate to the V-shaped probe holder. Insert the end of the platform/cable assembly and tighten the screws holding the top plate to secure the probe.

Tip Retaining Clip

The Tip Retaining Clip (PK600ST-3) is an aid for holding the SI Interconnect Leads in place while making measurements or when soldering the damping resistors to the test points of the board under test. The Clip comes standard with Small Tip Amplifier Modules (on page 10) along with a set of 10 white and 10 black Adhesive Pads (Dxx0-PT-TAPE) used for mounting the clip to the board.

NOTE: In extreme conditions, the Tip Retaining Clip is rated to 100 °C and adhesives are rated to 90 °C.

Fastening The Clip To The Board

Fasten the clip to the board by removing the small piece of protection paper from one side of the adhesive pad and mount the pad to the underside of the clip. If necessary, use alcohol to clean the section of the board where the clip is mounted to remove any grease or flux residue.

Remove the protective paper from the other side of the adhesive pad and mount the clip to the desired location on the board. Apply pressure to the clip for at least several seconds to assure proper adhesion (shown previous).

The adhesive pad with the tab is still be visible and stays attached to the adhesive pad. The tab is used to remove the clip from the board.

NOTE: Maximum strength of the adhesive pad is obtained after about 30 minutes.
**MOVING AND POSITIONING TIP RETAINING CLIP**
Always apply pressure to the pad (as follows) to prevent any shifting while bending the arms and/or moving the probe adapter portion of the clip (typically done while positioning or attaching the probe). This is especially important if moving and positioning before the adhesive pads have properly cured.

**ATTACHING THE PROBE TO THE CLIP**
Attach the probe by positioning the cable of the module on top of the clip and sliding the input board of the module into the grooves. While moving the probe into position for measurement, apply pressure to the mounting pad to prevent the adhesive pad from moving and losing its adhesion.

**REMOVING THE TIP RETAINING CLIP**
Remove the Retaining Clip from the board by pulling on the tab of the adhesive pad. The clip can now be removed easily without leaving any adhesive residue and can be used in another application using a new adhesive pad.
WaveLink Low Bandwidth (4 GHz and 6 GHz) Differential Probe

Platform/Cable Assembly Mounting Kit

The Platform/Cable Assembly Mounting Kit (PK600ST-4) can be used to support the platform/cable assembly and relieve stress on interconnect leads when the test points are located close to the edge of the board under test. The kit includes one Board Edge Clip and four Adhesive-backed Platform/Cable Assembly Clamps.

Board Edge Clip

The Board Edge Clip can be used to give support to the probe and Interconnect Lead when the test points are located close to the edge of the board under test. It’s also useful for holding the probe assembly while soldering the solder-in interconnect lead to your device under test.

Slide the probe cable into the clamp opening and move the probe so that the probe’s strain relief is located in the opening. Close the clamp.

Adhesive Backed Platform/Cable Assembly Clamps

The Adhesive Backed Platform/Cable Assembly Clamp provides additional support to the Platform/Cable Assembly and Interconnect Lead anywhere on the board.

Connection Guides

Probe connection guides are designed to make it easy to electrically isolate the two probe tips when browsing. They also greatly reduce accidental and unwanted contact across probe points. Before attaching connection guides, clean the PCA assembly area with IPA or another cleaner to remove oils. Then, apply with a light pressure, release, and let set for one hour.
Controlling the Probe from the Oscilloscope

Before Using the Probe
- Ensure the oscilloscope’s Windows updates are current.
- If using the probe with an SDA 9000, 11000, 13000, or 18000 oscilloscope, download and install the most recent version of the Microsoft Core XML Services (MSXML) Service Pack before using your probe. Other service packs may be required for MSXML to work properly.
- Install the latest version of X-StreamDSO oscilloscope firmware.

Controlling Vertical Response
When the fully assembled probe is connected to a MAUI oscilloscope, the oscilloscope recognizes the probe and opens the respective Channel (Cn) setup dialog. Refer to your oscilloscope’s Operator’s Manual for specific operation of the Vertical controls.

Behind the Cn dialog is a dialog of controls for the probe (the name varies based on the amplifier module you have attached).
- The Attributes frame shows the characteristics of the probe, such as Amplifier Bandwidth and Attenuation of probe signal.
- The Power On checkbox controls the operational state of the probe.
- The LED Active checkbox turns on/off AutoColor ID.
- Auto Zero initiates an Auto Zero cycle.
- Tip Select allows you to select the tip in use for proper calibrated response.
Power Control
Select the Power On checkbox to turn on power to the probe tip.

Newer, MAUI oscilloscopes feature Power Control. Power Control allows intermittent operation of a small tip modules and probe tip combinations during testing at elevated ambient temperatures to prevent overheating of the probe; as, for example, when testing the operation of test circuits in temperature chambers.

The intent of this feature is to keep the probe tip power off during the time when the chamber temperature is changing between tests. When the chamber temperature has stabilized and measurements are ready to be taken, the probe is powered on to facilitate measurements. The probe is then powered down while the chamber temperature is changing for the next test.

The time the probe can be operated at these elevated temperatures is a function of airflow, thermal conductivity of the probe in that environment, etc. For a starting estimate on time vs. temperature refer to the following table.

When the probe operates at an elevated ambient temperature, the wave shape is correct, but because it is outside the specified temperature range the amplitude may be uncalibrated.

If over-temperature does occur when used with a Teledyne LeCroy X-Stream oscilloscope, the probe automatically turns off the power applied to the probe, and the AutoColor ID on the probe body flashes in red. In addition, a warning message appears on the oscilloscope’s screen. When cooled down, reset the power again.

### Approximate Operating Time at Temperature for the D400A-AT and D600A-AT

<table>
<thead>
<tr>
<th>Temperature °C</th>
<th>Time</th>
</tr>
</thead>
<tbody>
<tr>
<td>Up to 40</td>
<td>Continuous</td>
</tr>
<tr>
<td>40 to 55</td>
<td>40 minutes</td>
</tr>
<tr>
<td>55 to 65</td>
<td>18 minutes</td>
</tr>
<tr>
<td>65 to 75</td>
<td>30 seconds</td>
</tr>
<tr>
<td>75 to 85</td>
<td>15 seconds</td>
</tr>
</tbody>
</table>
AutoColor ID

The AutoColor ID LEDs built into the platform/cable assembly immediately inform you of three conditions related to the probe:

- **Input channel** LEDs illuminate in the color of the channel to which the probe is connected.
- When the amplifier module is compatible with the platform/cable assembly to which it is connected, the green LED illuminates for about one second after the probe is connected to the oscilloscope. A continuous red light indicates the components are not compatible.
- If the probe is over-temperature, the red LED flashes. The probe is automatically shut down in this state (see Power Control). Unless the shut-down is caused by over-temperature, all LEDs are normally off when probe is powered down.

In some applications, it may be desirable to turn the probe’s AutoColor ID off by deselecting the LED Active checkbox on the Probe dialog.

**Tip Select**

The Probe dialog contains a **Tip Select** field. Select the tip you’re using before applying any other pre-processing functions to the input signal.

**CAUTION:** It is crucial to make the tip selection on this field as it results in the amplifier and tip combination having the response calibrated for at the factory. Failure to select the proper tip may result in inaccurate measurements. If you do not see the tip among the selections, return the probe to the Teledyne LeCroy factory for re-calibration.
**Auto Zero**

WaveLink probes incorporate an Auto Zero function to remove any DC offset from the probe. This function is available only when the probe is used with Teledyne LeCroy’s MAUI oscilloscopes, and must be invoked by the user. Perform Auto Zero after several minutes of warm-up, or when the probe is exposed to a large shift in ambient temperature.

Start an Auto Zero cycle by touching the **Auto Zero** button on the Probe dialog.

**CAUTION:** Disconnect the probe from the circuit before initializing AutoZero, or any DC component that is part of the Signal to be measured will be zeroed out.

Depending on the measurement accuracy desired and/or changes in ambient temperature where the probe is located, it may be necessary to perform Auto Zero more often. If the probe is disconnected from the oscilloscope and reconnected, repeat Auto Zero after suitable warm-up.

**Deskewing**

The Probe Characterization Fixture (PCF200) is provided as a standard accessory with WaveLink series platform/cable assemblies. The fixture can be used as a convenient way to deskew probes/oscilloscope channels.

**REQUIRED EQUIPMENT**

- PCF200
- Square-Pin (SP) lead or additional Solder-In (SI) lead
- 50 Ω terminator

**NOTE:** Alternatively, an LPA-K-A adapter and an SMA cable can be used.
**CONNECTING TO THE PCF200**

Place leads so that the positive tip contacts the center microstrip and the negative tip contacts the ground plane. Leads show the positive tip with a “+” sign.

For solder-in leads, press the black plastic tab on the PCF200 to open the clamp, placing the resistor tips under the clamp so that the + tip contacts the center microstrip and the – tip contacts the ground plane. Release the clamp so it holds the wires securely in place.

Place the Square Pin lead over the pins on the second circuit.
**DESKEW PROCEDURE**

1. Warm the oscilloscope for at least 20 minutes.

2. Connect the PCF200 to the oscilloscope’s Fast Edge output using the signal path indicated by the type of probe tip being used for the measurement:
   - The upper path (with the black clip) is for Solder-In (SI), QuickLink Solder-In (QL-SI), Quick-Connect (QC) and Adjustable Tip (AT) probe tips.
   - The lower circuit is for Square-Pin (SP) probe tips.
   
   **TIP:** For ease of connectivity, we recommend using the SP tip. However, the tip does not matter as long as you use the same tip to deskew each probe. On some oscilloscope models, the Fast Edge signal is output over the Aux Out interface. Go to Utilities > Utilities Setup > Aux Output to configure the output for Fast Edge.

3. Connect probes electrically in a single-ended arrangement using their designated area on the fixture:
   - Connect the positive side, indicated by a plus sign on the probe tip, to the signal trace (between the two white strips).
   - Connect the negative side to the ground plane (outside the white strips).

4. In order to minimize reflection, apply a 50 Ω terminator to the end of the signal path in use. If a 50 Ω terminator is not available, an SMA cable can be used to terminate the PCF200 to one of the oscilloscope’s outputs.

5. Connect the probe cable to C1.

6. Set the oscilloscope trigger type to “Edge”, trigger source to “Fast Edge”, timebase to 10 ns/div, and delay to zero. Start acquisition.
Once everything is properly set up, the oscilloscope display should look similar to the figure below. If there is no propagation delay due to the probe, and no internal oscilloscope channel propagation delay, the 50% trigger level will appear exactly centered on the oscilloscope grid. Any visible delay represents the amount of skew to be corrected.

7. Adjust the C1 Deskew value so that the 50% rising edge point is centered on the grid.
   - From the C1 setup dialog, enable Sinx/x Interpolation and set Averaging to 50 sweeps.
   - Adjust the Deskew value to move the rising edge of the trace toward the center of the grid.
   - Decrease the timebase to around 20 ps/div, and adjust the Deskew value so that the 50% rising edge point is centered on the grid, as shown in the image below:

8. Repeat this procedure for each probe using the same probe tip.

**NOTE:** Before deskewing the next probe, reset Averaging to 1 sweep and turn off Sinx/x Interpolation.
Maintenance

Cleaning
Clean the exterior of the probe and cable using a soft cloth moistened with water. Do not use abrasive agents, strong detergents, or other solvents as these may damage the probe.

⚠️ CAUTION: The probe case is not sealed and should never be immersed in any fluid.

Replacing Damping Resistors on the SI Lead

NOTE: Do not confuse the SI module damping resistors with the Quick Connect lead resistors. The SI replacement damping resistors are smaller. Resistors used in the D610-A, D620-A, D410-A, and D420-A have different values from those used in the older D350ST.

The external damping resistors locate the tip resistance as close to the device under test as possible, which minimizes tip inductance and capacitance and provides very favorable loading characteristics. However, these resistors are subject to mechanical stress and may periodically need to be replaced even if proper stress-relief precautions are taken. Replacement damping resistors are included with the probe, and replacement of these resistors is simple. Resistors are pre-cut to the right lead lengths, so all that is required is removal and attachment of the new resistor.

Follow these steps to correctly remove the damaged damping resistors and to solder a new resistor to your tip. It is assumed that the person performing the resistor replacement is familiar with fine-pitch soldering techniques.

1. Remove the old resistor tip and any remaining solder from the long solder pad using a fine-tip soldering iron, taking care not to de-solder the SMT resistors.
2. Use a soldering iron to pre-tin the pad. Wash the area with isopropyl alcohol to remove any residual flux.

⚠️ **CAUTION:** Avoid using excessive amounts of solder. Use the photographs in this topic as a reference for the proper amount of solder.

3. Align the damping resistor lead with the end of the tin pad and solder in place running the lead along the pad and over the via. Avoid using excessive amounts of solder. Use the photographs in this topic as a reference for the proper amount of solder.

4. Verify the following dimensions for:

<table>
<thead>
<tr>
<th>Resistor Lead Length</th>
<th>Resistor Gap to PCB Edge</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.090 +0.000 / -0.010 (inches)</td>
<td>0.050 - 0.025 (inches)</td>
</tr>
<tr>
<td>2.286 +0.000 / -0.254 (millimeters)</td>
<td>1.27 - 0.635 (millimeters)</td>
</tr>
</tbody>
</table>

**Replacing Tips and Sockets on the Positioner Tip**

**Replacing Spring-Loaded Tips**

A set of four replacement spring-loaded tips have been supplied with the Dx10-PT and Dx20-PT Positioner Tips. Under normal usage, the tips should last a very long time. However, in the event of breakage or damage, they can be easily replaced.

First, adjust the tip spacing to its maximum open position. Then, remove the old tip from the socket and insert a new tip, taking care to orient it in the correct direction. While replacing tips, mount the Dx10/Dx20-PT in a clamp, taking care to not adjust too tightly.
**Replacing Tip Sockets**

Two replacement tip sockets have been supplied with the Dx10-PT and Dx20-PT Positioner Tips. Under normal usage, the tip sockets should not need replacement. However, in the event of breakage or damage, new sockets can be soldered into place using the following steps:

1. Secure the positioner tip in a clamp to immobilize it while working. Using an appropriate fine-tip soldering iron for low mass components, apply heat and remove the damaged socket from the positioner tip circuit board.

2. Clean off the pad using the soldering iron. Clean oils and dirt in the area using deionized or distilled water and isopropyl alcohol. Inspect the pad for damage - damaged or loose sockets do not adhere properly.

3. Tin the pad using a no clean solder. Tin thickness should be .010” to .015” (2.5 to 4 mm).

4. Locate the socket so the closed end is slightly overhanging the end of the pad. This prevents solder from flowing into the socket insert hole. Align the socket sides with the pad sides and solder as shown. Leave proper clearance between the socket and pad sides when soldering.

5. Finally, clean the newly soldered assembly with deionized or distilled water.
Returning a Product for Service
Contact your local Teledyne LeCroy service center for calibration or other service. If the product cannot be serviced on location, the service center will give you a Return Material Authorization (RMA) code and instruct you where to ship the product. All products returned to the factory must have an RMA.

Return shipments must be prepaid. Teledyne LeCroy cannot accept COD or Collect shipments. We recommend air-freighting. Insure the item you’re returning for at least the replacement cost.

1. Remove all accessories from the device. If you need to return a D610-A, D620-A, D410-A, or D420-A module, be sure to include all Interconnect Leads and Tips (SI, QC, SP, PT). Do not include the manual.

2. Pack the product in its case, surrounded by the original packing material (or equivalent).

3. Label the case with a tag containing:
   - The RMA
   - Name and address of the owner
   - Product model and serial number
   - Description of failure or requisite service

4. Pack the product case in a cardboard shipping box with adequate padding to avoid damage in transit.

5. Mark the outside of the box with the shipping address given to you by Teledyne LeCroy; be sure to add the following:
   - ATTN: <RMA code assigned by Teledyne LeCroy>
   - FRAGILE

6. If returning a product to a different country:
   - Mark the shipment as a "Return of US manufactured goods for warranty repair/recalibration."
   - If there is a cost for the service, list the cost in the Value column and the original purchase price "For insurance purposes only."
   - Be very specific about the reason for shipment. Duties may have to be paid on the value of the service.
### Service Options

Defective probes or probe tip modules must be returned to a Teledyne LeCroy service facility for diagnosis and repair. Defective products under warranty are repaired or replaced.

Probes are warranted for a period of one year from shipment. The following extended warranty and service plans are available.

**NOTE:** For warranted accuracy, amplifiers must be returned for calibration with leads.

<table>
<thead>
<tr>
<th>Service Option</th>
<th>Product Code</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>D400A-AT-PB2-W3, D600A-AT-PB2-W3</td>
</tr>
<tr>
<td></td>
<td>D400A-AT-PB2-W5, D600A-AT-PB2-W5</td>
</tr>
<tr>
<td></td>
<td>D400A-AT-PB2-C3, D600A-AT-PB2-C3</td>
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<td>D400A-AT-PB2-T3, D600A-AT-PB2-T3</td>
</tr>
<tr>
<td></td>
<td>D400A-AT-PB2-T5, D600A-AT-PB2-T5</td>
</tr>
</tbody>
</table>

*CCNIST NIST traceable calibration with test data is available for D610-A, D620-A, D410-A, D420-A, D600A-AT and D400A-AT amplifier modules only when serialized to a WL-PLINK or WL-PBUS2 platform/cable assembly.
Returning a Product for Service
Contact your local Teledyne LeCroy service center for calibration or other service. If the product cannot be serviced on location, the service center will give you a Return Material Authorization (RMA) code and instruct you where to ship the product. All products returned to the factory must have an RMA.

**Return shipments must be prepaid.** Teledyne LeCroy cannot accept COD or Collect shipments. We recommend air-freighting. Insure the item you’re returning for at least the replacement cost.

1. Remove all accessories from the device.
2. Pack the product in its case, surrounded by the original packing material (or equivalent). Be sure to include all Interconnect Leads and Tips. Do not include the manual.
3. Label the case with a tag containing:
   - The RMA
   - Name and address of the owner
   - Product model and serial number
   - Description of failure or requisite service
4. Pack the product case in a cardboard shipping box with adequate padding to avoid damage in transit.
5. Mark the outside of the box with the shipping address given to you by Teledyne LeCroy; be sure to add the following:
   - ATTN: <RMA code assigned by Teledyne LeCroy>
   - FRAGILE
6. **If returning a product to a different country:**
   - Mark the shipment as a "Return of US manufactured goods for warranty repair/recalibration."
   - If there is a cost for the service, list the cost in the Value column and the original purchase price "For insurance purposes only."
   - Be very specific about the reason for shipment. Duties may have to be paid on the value of the service.
**Consumables and Replacement Parts**
The following parts may be ordered individually as replacements from your Teledyne LeCroy sales representative or Teledyne LeCroy Service Center.

<table>
<thead>
<tr>
<th>Item</th>
<th>Replacement Part Code</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Positioner Tip Parts</strong></td>
<td></td>
</tr>
<tr>
<td>Positioner Tip with Accessories</td>
<td></td>
</tr>
<tr>
<td><img src="image" alt="Positioner Tip with Accessories" /></td>
<td>RK-Dx10-PT-Kit</td>
</tr>
<tr>
<td></td>
<td>RK-Dx20-PT-Kit</td>
</tr>
<tr>
<td>Positioner Tip</td>
<td></td>
</tr>
<tr>
<td><img src="image" alt="Positioner Tip" /></td>
<td>Dx10-PT</td>
</tr>
<tr>
<td></td>
<td>Dx20-PT</td>
</tr>
<tr>
<td>Pogo Pin Tips for PT</td>
<td></td>
</tr>
<tr>
<td>(Qty. 4)</td>
<td>Dx10-PT-Tips</td>
</tr>
<tr>
<td></td>
<td>Dx20-PT-Tips</td>
</tr>
<tr>
<td>Pogo Tip Connection Guides</td>
<td></td>
</tr>
<tr>
<td><img src="image" alt="Pogo Tip Connection Guides" /></td>
<td>Dx10-PT-Guidess</td>
</tr>
<tr>
<td></td>
<td>Dx20-PT-Guidess</td>
</tr>
<tr>
<td>Item</td>
<td>Replacement Part Code</td>
</tr>
<tr>
<td>-----------------------------</td>
<td>--------------------------------------------</td>
</tr>
</tbody>
</table>
| XYZ Positioner              | Dx10-PT- XYZ-Positioner  
|                             | Dx20-PT- XYZ-Positioner                   |
| Adhesive Tape for XYZ Positioner  
(10 pieces each) | Dx10-PT-Tape  
|                             | Dx20-PT-Tape                               |
| Browser Wand for Positioner Tip  
| | Dx10-PT-Wand  
|                             | Dx20-PT-Wand                               |
| Interlock Pieces for Positioner Tip  
(6 pieces) | Dx10-PT-Interlock  
|                             | Dx20-PT-Interlock                          |
| Swivel for Positioner Tip    | Dx10-PT-Swivel  
<p>|                             | Dx20-PT-Swivel                             |</p>
<table>
<thead>
<tr>
<th>Item</th>
<th>Replacement Part Code</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Amplifier Module Parts</strong></td>
<td></td>
</tr>
<tr>
<td>Solder-In Tips</td>
<td>PKx10-SI PKx20-SI</td>
</tr>
<tr>
<td>(Qty. 5)</td>
<td></td>
</tr>
<tr>
<td>Solder-In Lead</td>
<td>Dx10-SI Dx20-SI</td>
</tr>
<tr>
<td>(with PK600ST-3)</td>
<td></td>
</tr>
<tr>
<td>Square Pin Lead</td>
<td>Dx10-SP Dx20-SP</td>
</tr>
<tr>
<td>(with Spare Resistors)</td>
<td></td>
</tr>
<tr>
<td>Quick Connect Lead</td>
<td>Dx10-QC Dx20-QC</td>
</tr>
<tr>
<td>(with Spare Resistors)</td>
<td></td>
</tr>
<tr>
<td>Ground Lead</td>
<td>PACC-LD005</td>
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<tr>
<td>(Qty. 4)</td>
<td></td>
</tr>
<tr>
<td>Ground Clip</td>
<td>PK006-4</td>
</tr>
<tr>
<td>(Qty. 2)</td>
<td></td>
</tr>
<tr>
<td>Item</td>
<td>Replacement Part Code</td>
</tr>
<tr>
<td>-------------------------------------</td>
<td>-----------------------</td>
</tr>
<tr>
<td><strong>Solder-in Probe Holder Kit</strong></td>
<td>PK600ST-3</td>
</tr>
<tr>
<td>(2 tip-retaining clips and 1 set of adhesive tape)</td>
<td></td>
</tr>
<tr>
<td><strong>Optional Tips</strong></td>
<td></td>
</tr>
<tr>
<td><strong>HiTemp-SI Lead</strong></td>
<td>Dx10-SI-HiTemp</td>
</tr>
<tr>
<td>(with Spare Resistors)</td>
<td>Dx20-SI-HiTemp</td>
</tr>
<tr>
<td><strong>HiTemp Cable</strong></td>
<td>Dx10-Cable-HiTemp</td>
</tr>
<tr>
<td>(1 Paired Cable)</td>
<td>Dx20-Cable-HiTemp</td>
</tr>
<tr>
<td><strong>QuickLink Adapter</strong></td>
<td>Dx10-QL</td>
</tr>
<tr>
<td></td>
<td>Dx20-QL</td>
</tr>
<tr>
<td><strong>QL-SI Tips</strong></td>
<td>Dx10-1QL-SI</td>
</tr>
<tr>
<td>(1- or 9-tip pack)</td>
<td>Dx10-9QL-SI</td>
</tr>
<tr>
<td></td>
<td>Dx20-1QL-SI</td>
</tr>
<tr>
<td></td>
<td>Dx20-9QL-SI</td>
</tr>
</tbody>
</table>
## WaveLink Low Bandwidth (4 GHz and 6 GHz) Differential Probe

<table>
<thead>
<tr>
<th>Item</th>
<th>Replacement Part Code</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Platform/Cable Assembly Parts</strong></td>
<td></td>
</tr>
<tr>
<td>Platform/Cable Assembly Mounting Kit</td>
<td>PK600ST-4</td>
</tr>
<tr>
<td>(1 Board Clip and 4 Clamps)</td>
<td></td>
</tr>
<tr>
<td>Probe Deskew Fixture</td>
<td>PCF200</td>
</tr>
<tr>
<td>Freehand Probe Holder</td>
<td>PACC-MS001</td>
</tr>
<tr>
<td>Deluxe Soft Carrying Case</td>
<td>SAC-03</td>
</tr>
<tr>
<td>Foam Insert for SAC-03</td>
<td>921079-00 for WL-PBUS and WL-PBUS2</td>
</tr>
<tr>
<td></td>
<td>921081-00 for WL-PLINK</td>
</tr>
<tr>
<td>Protective Storage Case</td>
<td>921083-00</td>
</tr>
<tr>
<td>Plastic Tray for Protective Storage Case</td>
<td>921078-00</td>
</tr>
</tbody>
</table>
Performance Verification

The following procedures can be used to verify basic operation and some of the warranted characteristics of a WaveLink Differential Probe. Performance Verification can be completed without removing the probe covers or exposing the user to hazardous voltages. No adjustments are provided.

Performance verification should be performed as the first part of annual calibration. It is recommended that the Functional Test be performed prior to the Performance Verification Procedure to assure all other non-warranted functions perform as specified.

Test results can be recorded on a photocopy of the “WaveLink LBW Differential Probe Test Record” on page 60. In the unlikely event a probe fails performance verification, it can be sent back to the local service center or the factory. See “Returning a Product for Service” (page 44).

Best practice is to complete the entire procedure for each combination of platform/cable assembly, probe amplifier, and lead. If more than one interconnect lead is being verified, copy and fill out a separate test record for each platform/cable assembly, amplifier module, and interconnect lead.

**NOTE:** If the probe system includes interconnect leads that are *not* serialized to the amplifier module and platform/cable assembly, then performance may not be verifiable.
Functional Test

The functional test can be used to verify the basic operation of a WaveLink Differential Probe when used with a Teledyne LeCroy oscilloscope.

**NOTE:** It is recommended that the Functional Test be performed prior to the Performance Verification Procedure to assure all other non-warranted functions perform as specified.

1. Connect the amplifier to the platform/cable assembly, then connect the body to Channel 1 of the oscilloscope.

   The instant the probe is connected to the oscilloscope, the AutoColor ID LEDs should illuminate GREEN for less than 1 second, then change to the color of the channel to which the probe is connected, indicating the probe is compatible with the oscilloscope.

2. Verify the probe AutoColor ID indicates the proper channel by disconnecting the probe and reconnecting it to the other channels, confirming the proper color LED illuminates.

3. Reconnect the probe to Channel 1. Turn on C1 trace.

4. Touch the C1 descriptor box to display the C1 setup dialog. Verify the correct probe model is shown on the tab following the C1 tab. (The D420-A is shown in the examples here.)

5. Open the Probe dialog.
6. Clear the **Power On** checkbox to verify the AutoColor ID LEDs turn OFF when probe power is OFF. Turn the power back ON by selecting the checkbox again.

   **NOTE:** The LEDs might still be illuminated at low intensity when turned off.

7. Clear the **Led On** checkbox to verify the AutoColor ID LEDs turn OFF when probe power is still ON. Turn LEDs back ON by selecting the checkbox again.

8. Set up the calibrator for performing the functional tests:
   - Choose **Utilities > Utilities Setup** from the menu bar.
   - Open the **Aux Output** tab.
   - Touch the **Square** button to obtain a square wave output signal.
   - Set the **Amplitude** to 1 Volt, **Frequency** to 1.00 kHz.
   - Verify the Aux Output settings are as shown below.
9. Connect PCF200 to the Aux Output connector using a BNC/SMA adapter.

10. Touch the C1 descriptor box, and on the C1 dialog set the probe sensitivity (V/div) to 200 mV/div and Offset to -500 mV.

11. Connect the + tip of the probe to the center trace of the PCF200, and the – tip to the shell (ground) of the PCF200.

12. Adjust the Timebase to 1 ms/div.

13. Verify the screen shows a square wave centered on the middle graticule line (refer to the following screen-shot). If no square wave is shown, the + channel of the probe may be faulty.
12. Reverse the polarity of the probe tips, connecting the + tip to ground and the − tip to the PCF200 center conductor.

13. Change the Offset to +500 mV. Verify that the screen again shows a square wave.
Verification Procedure
This procedure tests:

- Output zero
- Probe bandwidth
- Low frequency attenuation accuracy

**NOTE:** If testing with probe interconnect leads that are not serialized to the amplifier module and platform/cable assembly, performance may not be verifiable.

**Required Test Equipment**
The following table lists the test equipment, or their equivalents, required for the performance verification test. The procedure has been developed to minimize the number of parameters requiring calibration in the test instrumentation. Only the parameters listed in boldface in the Minimum Requirements column must be calibrated to the accuracy indicated. Because the input and output connector types may vary on different brands and models of test instruments, additional adapters or cables may be required.

<table>
<thead>
<tr>
<th>Description</th>
<th>Minimum Requirements</th>
<th>Example Test Equipment</th>
</tr>
</thead>
<tbody>
<tr>
<td>Oscilloscope with ProLink interface</td>
<td><strong>BW &gt; 6 GHz for D4xx</strong>&lt;br&gt;<strong>BW &gt; 8 GHz for D6xx</strong></td>
<td>WaveMaster 813 Zi</td>
</tr>
<tr>
<td>Calibration Fixtures (2)</td>
<td></td>
<td>PCF200&lt;br&gt;ProBus-CF01 for D4xx&lt;br&gt;ProLink-CF01 for D6xx</td>
</tr>
<tr>
<td>Digital Multimeter</td>
<td><strong>AC: 0.2% accuracy</strong> to measure 200 mV and 2 Vrms @ 1 kHz 6½ digit resolution</td>
<td>Keysight Technologies 34401A, Fluke 8842A-09, Keithley 2001</td>
</tr>
<tr>
<td>Oscillator/Function Generator</td>
<td>Sine Wave output, adjustable from 500 mV to 4 Vp-p (357 mV to 2.83 Vrms) at 70 Hz</td>
<td>Stanford Research Model DS340, Keysight Technologies 33120A, Leader LAG-120B</td>
</tr>
<tr>
<td>Microwave Signal Generator</td>
<td>Sine wave output 1GHz - &gt;8GHz 0dBm output</td>
<td>Anritsu MG3690C</td>
</tr>
<tr>
<td>ProBus-to-ProLink Adapter (ProBus probes only)</td>
<td></td>
<td>LPA-BNC Adapter</td>
</tr>
<tr>
<td>LPA-SMA Adapter</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BNC-to-Dual-Banana Adapter</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BNC-SMA Adapter</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Precision BNC Terminator</td>
<td></td>
<td>TERM-CF01</td>
</tr>
</tbody>
</table>
Preliminary Procedure

1. Connect the probe to the oscilloscope ProLink input. If the probe has a ProBus interface, use an LPA-BNC adapter to connect it to the ProLink interface.

2. Allow at least 20 minutes warm-up time for all test equipment before performing the Verification Procedure.

3. While the instruments are reaching operating temperature, print a copy of the Performance Verification Test Record (on page 60) and fill in the necessary data.

Output Zero

1. Remove any tips from the probe amplifier.

2. Set parameter P1 to measure the Mean of the probe channel (C3 is shown here). Turn on statistics.

3. On the Probe dialog, touch Auto Zero.

4. When Auto Zero is complete, set the channel V/div to the most sensitive setting.

5. Record the statistical mean of the Mean measurement (P1) on the Performance Verification Test Record.
**Probe Bandwidth**

1. Set the microwave signal generator to 1 GHz at 0 dBm output.
2. Connect the PCF200 to the oscilloscope C4 input using an LPA-SMA adapter.
3. Connect the signal generator to the C4 input through the PCF200.
4. Attach the probe SI tip to the PCF200 using the black clip.
5. Set up the oscilloscope as follows:
   - C3 and C4 100 mV/Div
   - Timebase 10 ns/Div
   - Trigger on C4 edge, level = 0V
   - Measurements:
     - P1 sdev of C3
     - P2 sdev of C4
     - P3 ratio of P1/P2
     - P4 freq of C4
6. Monitor the ratio measurement as the frequency of the signal generator is gradually increased.

The probe bandwidth is defined as the frequency at which the probe amplitude is 3 dB down from the input signal amplitude. This would be the frequency at which the ratio measurement P3 drops to 0.7071.

7. On the Test Record, record the frequency of the signal generator when the ratio first drops to 0.7071.

**Attenuation Accuracy**

1. Set the function generator to:
   - Sine wave output
   - 50 Hz
   - Output Term = HiZ
   - Amplitude = 200 mVrms

2. Set the Digital Multimeter (DMM) to measure ACV.

3. Connect the function generator to the DMM using a BNC cable and BNC-to-Dual-Banana adapter.
4. Adjust the function generator amplitude so that measured voltage on the DMM is 200 mVrms ± 0.1 mV (± 0.5 %).

5. Remove the BNC cable and connect the PCF200 to the function generator output using a BNC-to-SMA adapter.

6. Connect the probe to an oscilloscope channel using the ProBus-CF01 (for D4xx probes) or the ProLink-CF01 (for D6xx probes).

7. Install the TERM-CF01 at the DMM input.

8. Connect the ProBus/ProLink-CF01 output to the TERM-CF01.

9. Set the oscilloscope channel where the probe is connected to the smallest V/Div value.

10. Connect the probe tip to the PCF200.

11. Open the Probe dialog and on the Low Attenuation Value line of the Test Record, record the Attenuation value that is displayed on the dialog.

12. Record the value measured on the DMM on the Low Attenuation DMM line of the Test Record.

13. Multiply the Low Attenuation Value by the Low Attenuation DMM and record that as the Amplitude.

14. Subtract 200 mV from the Amplitude, then divide by 200 to calculate the Percent Error.
15. Change the probe channel sensitivity to the largest V/Div value.

16. Open the Probe dialog, and on the **High Attenuation Value** line of the Test Record, record the Attenuation value that is displayed on the dialog.

17. Record the value measured on the DMM on the **High Attenuation DMM** line of the Test Record.

18. Multiply the High Attenuation Value by the High Attenuation DMM and record that as the **Amplitude**.

19. Subtract 200 mV from the Amplitude, then divide by 200 to calculate the **Percent Error**.

**Performance Verification Test Record**

Permission is granted to copy the following page to record the results of measurements made during the performance verification of the WaveLink Low Bandwidth Differential Probe. File the completed record as required by applicable internal quality procedures.

Each section of the record corresponds to one test in the performance verification procedure. Numbers preceding each row correspond to the steps that require the recording of data.

**NOTE:** Use a new Test Record for each combination of platform/cable assembly, amplifier, and tip.
### WaveLink LBW Differential Probe Test Record

**Technician___________________________________________________**  **Test Date________________________________**

#### Items Tested

<table>
<thead>
<tr>
<th>Instrument</th>
<th>Model</th>
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<th>Calibration Due Date</th>
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<tr>
<td>Cable Assembly</td>
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</tr>
<tr>
<td>Amplifier</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Tip</td>
<td></td>
<td></td>
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</tr>
</tbody>
</table>

#### Equipment Used

<table>
<thead>
<tr>
<th>Instrument</th>
<th>Model</th>
<th>Serial Number</th>
<th>Calibration Due Date</th>
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</thead>
<tbody>
<tr>
<td>Oscilloscope</td>
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<td></td>
<td></td>
</tr>
<tr>
<td>Digital Multimeter</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Function Generator</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Signal Generator</td>
<td></td>
<td></td>
<td></td>
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</tbody>
</table>

#### Output Zero

<table>
<thead>
<tr>
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<th>Description</th>
<th>Intermediate Data</th>
<th>Test Result</th>
</tr>
</thead>
<tbody>
<tr>
<td>5</td>
<td>Output Zero</td>
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<td>mV</td>
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</table>

#### Probe Bandwidth

<table>
<thead>
<tr>
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</tr>
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<tbody>
<tr>
<td>7</td>
<td>Frequency</td>
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<td>GHz</td>
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</table>

#### Low Frequency Attenuation Accuracy

<table>
<thead>
<tr>
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<th>Intermediate Data</th>
<th>Test Result</th>
</tr>
</thead>
<tbody>
<tr>
<td>11</td>
<td>Low Attenuation Value</td>
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<td></td>
</tr>
<tr>
<td>12</td>
<td>Low Attenuation DMM</td>
<td>mVrms</td>
<td></td>
</tr>
<tr>
<td>13</td>
<td>Amplitude (Value x DMM)</td>
<td>mVrms</td>
<td></td>
</tr>
<tr>
<td>14</td>
<td>Percent Error</td>
<td></td>
<td>%</td>
</tr>
<tr>
<td>16</td>
<td>High Attenuation Value</td>
<td></td>
<td></td>
</tr>
<tr>
<td>17</td>
<td>High Attenuation DMM</td>
<td>mVrms</td>
<td></td>
</tr>
<tr>
<td>18</td>
<td>Amplitude (Value x DMM)</td>
<td>mVrms</td>
<td></td>
</tr>
<tr>
<td>19</td>
<td>Percent Error</td>
<td></td>
<td>%</td>
</tr>
</tbody>
</table>
Reference Material

Probe Input Impedance and Loading
Attaching any probe to a test circuit adds some loading to the circuit under test. In most applications the high impedance of the probe, compared to the impedance of the circuit under test, imparts an insignificant load to the test circuit. However, at very high frequencies the capacitive reactance of the Probe Tip Module or Interconnect Lead may load the circuit enough to affect the measurement. These probes are designed to minimize these effects at high frequencies. Refer to the figures in this topic for equivalent input circuit information.

These circuits represent the aggregate load placed on the test circuit, but not the actual input circuit of the probe. For critical applications, you can enter the information of your module or lead into SPICE to accurately represent the probe loading.

**NOTE:** Avoid degrading the high frequency performance of the probe and do not extend the input pins on the module.

To help determine the loading of the probe, some of the figures in this topic show loading impedance plots for the different modules and leads. For more information on probe loading, please refer to the Deskew instructions on p.35.

*Input Loading on Dx00A-AT*

![Diagram of D600A-AT, D400A-AT Equivalent Input Circuit]

D600A-AT, D400A-AT Equivalent Input Circuit
WaveLink Low Bandwidth (4 GHz and 6 GHz) Differential Probe

**D600A-AT, D400A-AT Input Impedance**

![Graph showing input impedance vs frequency for Differential and Single-Ended modes.](image)

*Diagram: Equivalent circuit for D600A-AT, D400A-AT input impedance.*

- 1 nH
- 3 nH
- 130 Ω
- 2 kΩ
- 0.2 pF
Input Loading on Dx10 Tips*

![Graph showing input loading on Dx10 Tips]

*Dx10 SI/QC/SP/PT/QL-SI/HiTemp and Dx20-QL-SI Input Impedance

* QL-SI and HiTemp same curve as SI tips. Input loading for the Dx20-QL-SI is the same as for the Dx10 tips.

![Equivalent Input Circuit Diagram]
WaveLink Low Bandwidth (4 GHz and 6 GHz) Differential Probe

**Dx10-SI, Dx10-HiTemp, Dx10-QL-SI, and Dx20-QL-SI Single-ended Impedance**

**Dx10-QC Equivalent Input Circuit**
Dx10-SP Equivalent Input Circuit

Dx10-PT Equivalent Input Circuit
WaveLink Low Bandwidth (4 GHz and 6 GHz) Differential Probe

Dx10-PT Impedance Graph

Input Loading on Dx20 Tips

Dx20 SI/QC/SP/PT/HiTemp and D600A-AT Input Impedance
* HiTemp same curve as SI tips. Input loading for the Dx20-QL-SI is the same as for the Dx10 tips.

Dx20-SI and Dx20-HiTemp Equivalent Input Circuit

Dx20-SI and Dx20-HiTemp Impedance Graph
WaveLink Low Bandwidth (4 GHz and 6 GHz) Differential Probe

Dx20-QC Equivalent Input Circuit

Dx20-SP Equivalent Input Circuit
Dx20-PT Equivalent Input Circuit

Dx20-PT Impedance Graph
Offset

D600A-AT and D400A-AT Amplifiers
Offset for the WaveLink Series probe is provided by Teledyne LeCroy’s X-Stream based oscilloscopes. This allows you to remove a DC bias voltage from the input signal while maintaining DC coupling.

To prevent displaying a clipped waveform from overdriving the probe, the available offset changes as a function of the V/Div setting of the oscilloscope.

The following equation determines the available offset as a function of oscilloscope sensitivity:

\[
\text{MaximumOffset} = \pm|V - 4x \text{ V/div}|
\]

where:

- \( V \) is the maximum range of the probe, 2.4 for the D600A-AT or D400A-AT
- \( \text{V/div} \) is the selected scale factor

As can be seen, the maximum offset for the probe with either the D600A-AT or D400A-AT is 2.4 V, while the minimum offset is 0 Volt at a scale factor of 0.6 V/div. (0.6 V/div is the minimum sensitivity available when using the D600A-AT or D400A-AT adjustable tip.

When the WaveLink series probe is used with a same bandwidth oscilloscope, the probe offset is controlled with the channel OFFSET knob.

Sometimes it may be desirable to display a waveform as a reference signal where a large display amplitude may not be necessary. Perhaps a timing reference when amplitude details are not needed. In such a case, the oscilloscope’s zoom function can be used to reduce the displayed height of the reference signal. (Refer to your oscilloscope’s online help for operation of the zoom function.)

D610-A, D620-A, D410-A, and D420-A Amplifiers
These probes all have full offset capability over their entire V/Div range.
Dynamic Range
WaveLink D600A-AT and D400A-AT probes have no gain or attenuation control. However, WL-PLINK (D610-A, D620-A modules) and WL-PBUS (D410-A, D420-A modules) do provide gain and attenuation controls.

The system attenuation is fixed at ÷2.5 when using an AT, PT, D610-A, or D620-A modules; or at ÷5 for the D410-A or D420-A.

The WaveLink series probes are always DC coupled (no AC coupling is provided). Therefore, care must be exercised to avoid exceeding the common mode range. Because the common mode signal is rejected by the probe and is not displayed, changes in the amplitude of the common mode component are not apparent to the user. Exceeding the common mode range may introduce distortion to the probe’s output signal.

<table>
<thead>
<tr>
<th>Specifications</th>
<th>D610-A, D410-A</th>
<th>D620-A, D420-A</th>
<th>D600A-AT, D400A-AT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Input Dynamic Range</td>
<td>±1.25 V</td>
<td>±2.5 V</td>
<td>±2.4 V</td>
</tr>
<tr>
<td>Input Common Mode Voltage</td>
<td>±4 V</td>
<td>±4 V</td>
<td>±2.4 V</td>
</tr>
<tr>
<td>Input Offset Voltage</td>
<td>±3 V</td>
<td>±3 V</td>
<td>0 V</td>
</tr>
<tr>
<td>Minimum Probe Attenuation</td>
<td>1.0X</td>
<td>1.9X</td>
<td>÷2.5</td>
</tr>
</tbody>
</table>

**NOTE:** Each probe has unique attenuation values programmed into memory. The value changes with your specific V/div setting. View your actual attenuation from the Probe dialog.

Differential Mode and Common Mode
Differential probes sense the voltage difference which appears between the + input and − input. This voltage is referred to as the Differential Mode or Normal Mode voltage. The voltage component which is referenced to earth and is identical on both inputs is rejected by the amplifier. This voltage is referred to as the Common Mode voltage and can be expressed as:

\[ V_{CM} = \frac{V_{+input} + V_{-input}}{2} \]
Differential Mode Range and Common Mode Range

Differential Mode range is the maximum signal that can be applied between the + and - inputs without overloading the amplifier/amplifier, which otherwise would result in clipping or distorting of the waveform measured by the oscilloscope.

The Common Mode Range is the maximum voltage with respect to earth ground that can be applied to either input. Exceeding the common mode range can result in unpredictable measurements. Because the Common Mode signal is normally rejected, and not displayed on the oscilloscope, the user needs to be careful to avoid accidentally exceeding the common mode range.

Because the input signal of a differential amplifier is not referenced to ground, the concept of \( V_{\text{peak}} \) versus \( V_{\text{peak-peak}} \) may be confusing.

With a ground referenced signal, \( V_{\text{peak}} \) is the maximum instantaneous voltage amplitude the signal will have with respect to ground. In a differential system, there is no ground reference. Therefore, the Differential Mode Range refers to the maximum instantaneous amplitude of the signal difference between the positive input and the negative input. Since most amplifiers have symmetrical bipolar inputs, the value is generally expressed as an absolute value, and can have either polarity.

For example, an amplifier with a differential mode rating of ±1 V can have a maximum voltage difference appearing at any instant in time of 1 V between the inputs. The polarity could be either positive or negative. This does not imply that the number can be doubled to 2 volts. For clarity, consider the following table of absolute voltages applied to the inputs of a differential amplifier that has a differential mode range of ±1 V and a common mode range of ±5 V:

<table>
<thead>
<tr>
<th>Voltage + input to ground</th>
<th>Voltage – input to ground</th>
<th>Difference</th>
<th>Comment</th>
</tr>
</thead>
<tbody>
<tr>
<td>+1.5 V</td>
<td>+0.8 V</td>
<td>+0.7 V</td>
<td>OK: within ±1 V range</td>
</tr>
<tr>
<td>-1.5 V</td>
<td>-0.8 V</td>
<td>-0.7 V</td>
<td>OK: within ±1 V range</td>
</tr>
<tr>
<td>+0.8 V</td>
<td>-0.1 V</td>
<td>+0.9 V</td>
<td>OK: within ±1 V range</td>
</tr>
<tr>
<td>+1.0 V</td>
<td>-1.0 V</td>
<td>+2.0 V</td>
<td>Out of range: exceeds ±1 V</td>
</tr>
<tr>
<td>+6.5 V</td>
<td>+6.0 V</td>
<td>0.5 V</td>
<td>Exceeds ±5 V common mode range</td>
</tr>
<tr>
<td>1.5 V pk-pk sine</td>
<td>Ground</td>
<td>0.75 Vpeak</td>
<td>OK: within ±1 V range</td>
</tr>
</tbody>
</table>

Some amplitude is specified as peak to peak. The differential amplifier peak-to-peak range is twice the peak differential mode range specification (at any instant in time) as the maximum voltage amplitude signal is one-half of the peak-to-peak value.

In a balanced differential system, the signal on each output is an inverted copy of the other input. For example, an LVDS system may have a pair of outputs, each of which has a voltage swing of 0 to +370 mV. A logic 1 would be represented when the + output is at +370 mV, while the - output is at 0
V. A logic zero is the opposite polarity: the + output at 0 V and the - output at +370 mV. Note that even though both outputs swing 370 mV, the maximum difference voltage between them at any instant is still within ±370 mV. So, this signal could be measured with a differential amplifier that has a differential mode range of ±400 mV.

**Common Mode Rejection Ratio**

The ideal differential probe/amplifier would sense and amplify only the differential mode voltage component and reject the entire common mode voltage component. Real differential amplifiers are not perfect, and a small portion of the common mode voltage component appears at the output. Common Mode Rejection Ratio (CMRR) is the measure of how much the amplifier rejects the common mode voltage component. CMRR is equal to the differential mode gain (or normal gain) divided by the common mode gain. Common mode gain is equal to the output voltage divided by the input voltage when both inputs are driven by only the common mode signal. CMRR can be expressed as a ratio (e.g., 10,000:1) or implicitly in dB (e.g., 80 dB). Higher numbers indicate greater rejection (better performance).

The first order term determining the CMRR is the relative gain matching between the + and − input paths. Obtain high CMRR values by precisely matching the input attenuators in a differential amplifier. The matching includes the DC attenuation and the capacitance which determines the AC attenuation. As the frequency of the common mode component increases, the effects of stray parasitic capacitance and inductance in determining the AC component become more pronounced. The CMRR becomes smaller as the frequency increases. Therefore, the CMRR is usually specified in a graph of CMRR versus common mode frequency.

The common mode frequency in these graphs is assumed to be sinusoidal. In real life applications, the common mode signal is seldom a pure sine wave. Signals with pulse wave shapes contain frequency components much higher than the repetition rate may suggest. This makes it very difficult to predict actual performance in the application for CMRR-versus-frequency graphs. The practical application of these graphs is to compare the relative common mode rejection performance between different probes and amplifiers.
Technical Support

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Registered users can contact their local Teledyne LeCroy service center at the number listed on our website. You can also submit Technical Support requests via the website at:

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Specifications
Please refer to the product datasheet at teledynelecroy.com for detailed specification information.

NOTE: Specifications are subject to change without notice.
Certifications
Teledyne LeCroy certifies compliance to the following standards as of the time of publication. See the EC Declaration of Conformity certificate shipped with your product for the current certifications.

EMC Compliance
EC DECLARATION OF CONFORMITY - EMC
The product meets the intent of EC Directive 2014/30/EU for Electromagnetic Compatibility. Compliance was demonstrated to the following specifications as listed in the Official Journal of the European Communities:

EN 61326-1:2013, EMC requirements for electrical equipment for measurement, control, and laboratory use. ¹ ² ³

1. Emissions which exceed the levels required by this standard may occur when the product is connected to a test object.
2. This product is intended for use in nonresidential areas only. Use in residential areas may cause electromagnetic interference.
3. To ensure compliance with the applicable EMC standards, use high-quality shielded interface cables.

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D-69126 Heidelberg
Germany
Tel: +49 6221 82700

AUSTRALIA & NEW ZEALAND DECLARATION OF CONFORMITY—EMC
The product complies with the EMC provision of the Radio Communications Act per the following standards, in accordance with requirements imposed by Australian Communication and Media Authority (ACMA):

AS/NZS CISPR 11:2011 Radiated and Conducted Emissions, Group 1, Class A

Australia / New Zealand Contacts:*
RS Components Pty Ltd.  RS Components Ltd.
Suite 326 The Parade West  Unit 30 & 31 Warehouse World
Kent Town, South Australia 5067  761 Great South Road
Penrose, Auckland, New Zealand

* Visit teledynelecroy.com/support/contact for the latest contact information.
Safety Compliance
EC Declaration of Conformity – Low Voltage
The product meets the intent of EC Directive 2014/35/EU for Product Safety. Compliance was demonstrated to the following specifications as listed in the Official Journal of the European Communities:

IEC/EN 61010-031:2015 Safety requirements for electrical equipment for measurement, control, and laboratory use – Part 031: Safety requirements for hand-held probe assemblies for electrical measurement and test.

Environmental Compliance
End-Of-Life Handling
The probe is marked with this symbol to indicate that it complies with the applicable European Union requirements to Directives 2012/19/EU and 2013/56/EU on Waste Electrical and Electronic Equipment (WEEE) and Batteries.

The probe is subject to disposal and recycling regulations that vary by country and region. Many countries prohibit the disposal of waste electronic equipment in standard waste receptacles. For more information about proper disposal and recycling of your Teledyne LeCroy product, please visit teledynelcroy.com/recycle.

Restriction of Hazardous Substances (RoHS)
The probe and its accessories conform to the 2011/65/EU RoHS2 Directive.
Warranty
Teledyne LeCroy warrants this oscilloscope accessory for normal use and operation within specification for a period of one year from the date of shipment. Spare parts, replacement parts and repairs are warranted for 90 days.

In exercising its warranty, Teledyne LeCroy, at its option, will either repair or replace any assembly returned within its warranty period to the Customer Service Department or an authorized service center. However, this will be done only if the product is determined by Teledyne LeCroy’s examination to be defective due to workmanship or materials, and the defect is not caused by misuse, neglect, accident, abnormal conditions of operation, or damage resulting from attempted repair or modifications by a non-authorized service facility.

The customer will be responsible for the transportation and insurance charges for the return of products to the service facility. Teledyne LeCroy will return all products under warranty with transportation charges prepaid.

This warranty replaces all other warranties, expressed or implied, including but not limited to any implied warranty of merchantability, fitness or adequacy for any particular purposes or use. Teledyne LeCroy shall not be liable for any special, incidental, or consequential damages, whether in contract or otherwise.